IN THE UNITED STATES PATENT AND TRADEMARK OF

pplicants:

Entley, William R.; Langan, John G.; Hall, Randy

gnee:

Novellus Systems, Inc.

In Situ Plasma Process To Remove Fluorine Residues From The Interior

Surfaces Of A CVD Reactor

Serial No.:

10/003,908

Filing Date:

November 1, 2001

Examiner:

Unassigned

Group Art Unit:

Unassigned

Docket No.:

M-11021 US

San Jose, California

March 8, 2002

COMMISSIONER FOR PATENTS Washington, D.C. 20231

> INFORMATION DISCLOSURE STATEMENT **UNDER 37 CFR § 1.97(b)**

Dear Sir:

Pursuant to 37 C.F.R. § 1.56, § 1.97 and § 1.98, the documents listed on the accompanying form PTO-1449 are called to the attention of the Examiner for the above patent application. Copies of these documents are enclosed.

Citation of these documents shall not be construed as:

- an admission that the documents are necessarily prior art with respect to the 1. instant invention;
  - 2.
- a representation that a search has been made; or an admission that the information cited herein is, or is considered to be, mate 3.

patertability as defined in § 1.56(b).

I hereby cartify that this correspondence is being deposited with the United States Fossal Service as First Class Mail in an envelope addressed to: Com. rissioner for Patents, Washington, D.C. 20231. on March 8, 2002.

Attorney for Applicant(s)

Date of Signature

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Respectfully submitted,

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